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PATENT
450100-05033

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Mitsutoshi SHINKAI et al.
International Application No.: PCT/JP04/004877
International Filing Date: April 2, 2004
For: RECORDING CONTROL APPARATUS AND
METHOD, PROGRAM, AND STORAGE MEDIUM

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Enclosed are copies of the publications, which were cited in the International Search Report of International Application No. PCT/JP04/004877. Also enclosed is a copy of Form PTO-1449 and the International Search Report.

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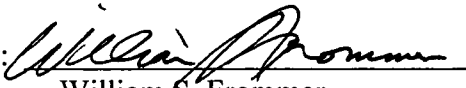
REMARKS

Entry of this Information Disclosure Statement and an early examination on the merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

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Enclosures

Based on Form PTO-1449 (3/90)	ATTY. DOCKET NO. 450100-05033	SERIAL NO. 10/516678 Filed Concurrently Herewith
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LIST OF REFERENCES CITED BY APPLICANT
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
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FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
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/H.D./	AH	EP 1 278 371	01/22/03	Europe			
/H.D./	AI	JP 2001-189940	07/10/01	Japan			
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/H.D./	AO	EP 1 102 277	05/23/01	Europe			
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